

**Search Notes**

Application/Control No.

10/692,093

Examiner

Eric B. Chen

Applicant(s)/Patent under  
Reexamination

BIAN, JINRU

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search (UPDATED)	12/12/2005	EC
EAST (all databases) (UPDATED)	12/12/2005	EC
438/690-693; 252/79.1; 510/175,176 216/88-91 (text search only) (UPDATED)	12/12/2005	EC